



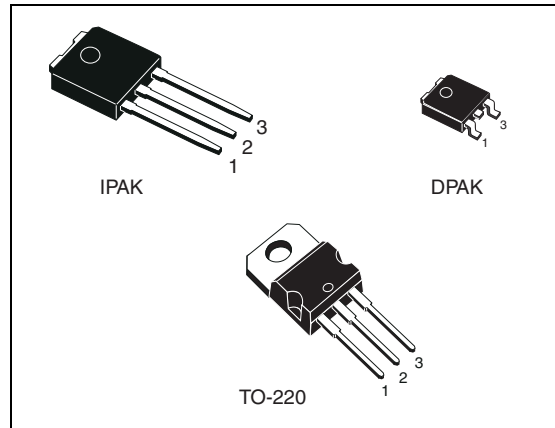
# STD27N3LH5, STP27N3LH5 STU27N3LH5

N-channel 30 V, 0.014  $\Omega$ , 27 A, DPAK, IPAK, TO-220  
STripFET™ V Power MOSFET

## Features

Type	V <sub>DSS</sub>	R <sub>DS(on) max</sub>	I <sub>D</sub>
STD27N3LH5	30 V	0.019 $\Omega$	27 A
STP27N3LH5	30 V	0.020 $\Omega$	27 A
STU27N3LH5	30 V	0.020 $\Omega$	27 A

- R<sub>DS(on)</sub> \* Q<sub>g</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- Very low switching gate charge
- High avalanche ruggedness
- Low gate drive power losses



## Application

- Switching applications

## Description

This STripFET™V Power MOSFET technology is among the latest improvements, which have been especially tailored to achieve very low on-state resistance providing also one of the best-in-class figure of merit (FOM).

Figure 1. Internal schematic diagram

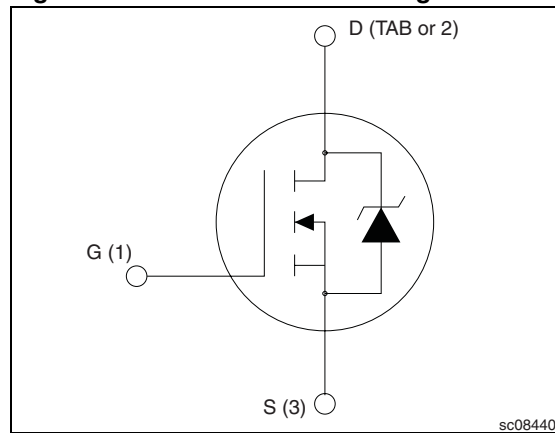


Table 1. Device summary

Order codes	Marking	Package	Packaging
STD27N3LH5	27N3LH5	DPAK	Tape and reel
STU27N3LH5	27N3LH5	IPAK	Tube
STP27N3LH5	27N3LH5	TO-220	Tube

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value		Unit
		DKPAK, IPAK	TO-220	
$V_{DS}$	Drain-source voltage ( $V_{GS} = 0$ )	30		V
$V_{GS}$	Gate-Source voltage	$\pm 22$		V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$	27		A
$I_D$	Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$	19		A
$I_{DM}^{(2)}$	Drain current (pulsed)	108		A
$P_{TOT}$	Total dissipation at $T_C = 25\text{ }^\circ\text{C}$	30	45	W
	Derating factor	0.2		W/ $^\circ\text{C}$
$E_{AS}^{(3)}$	Single pulse avalanche energy	50		mJ
$T_J$ $T_{stg}$	Operating junction temperature Storage temperature	- 55 to 175		$^\circ\text{C}$

1. Limited by wire bonding
2. Pulse width limited by safe operating area
3. Starting  $T_J = 25\text{ }^\circ\text{C}$ ,  $I_D = 21\text{ A}$ ,  $L = 0.2\text{ mH}$

**Table 3. Thermal resistance**

Symbol	Parameter	Value		Unit
		DKPAK, IPAK	TO-220	
$R_{thJC}$	Thermal resistance junction-case max	5	3.33	$^\circ\text{C/W}$
$R_{thJA}$	Thermal resistance junction-case max	100		$^\circ\text{C/W}$
$T_J$	Maximum lead temperature for soldering purpose	275		$^\circ\text{C}$

## 2 Electrical characteristics

( $T_{CASE} = 25\text{ °C}$  unless otherwise specified)

**Table 4. Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown Voltage	$I_D = 250\ \mu\text{A}$ , $V_{GS} = 0$	30			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 30\text{ V}$ $V_{DS} = 30\text{ V}$ , $T_c = 125\text{ °C}$			1 10	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 22\text{ V}$			$\pm 100$	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250\ \mu\text{A}$	1			V
$R_{DS(on)}$	Static drain-source on resistance	$V_{GS} = 10\text{ V}$ , $I_D = 13.5\text{ A}$ SMD version		0.015 0.014	0.020 0.019	$\Omega$ $\Omega$
		$V_{GS} = 4.5\text{ V}$ , $I_D = 13.5\text{ A}$ SMD version		0.021 0.020	0.028 0.027	$\Omega$ $\Omega$

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$ , $V_{GS} = 0$	-	475	-	pF
$C_{oss}$	Output capacitance			97		pF
$C_{rss}$	Reverse transfer capacitance			19		pF
$Q_g$	Total gate charge	$V_{DD} = 15\text{ V}$ , $I_D = 27\text{ A}$	-	4.6	-	nC
$Q_{gs}$	Gate-source charge	$V_{GS} = 5\text{ V}$		1.7		nC
$Q_{gd}$	Gate-drain charge	(Figure 16)		1.9		nC
$Q_{gs1}$	Pre $V_{th}$ gate-to-source charge	$V_{DD} = 15\text{ V}$ , $I_D = 27\text{ A}$	-	0.67	-	nC
$Q_{gs2}$	Post $V_{th}$ gate-to-source charge	$V_{GS} = 5\text{ V}$ (Figure 21)		0.84		nC
$R_G$	Gate input resistance	$f = 1\text{ MHz}$ gate bias = 0 test signal level = 20 mV open drain	-	2.5	-	$\Omega$

**Table 6. Switching on/off (resistive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ $t_r$	Turn-on delay time Rise time	$V_{DD} = 15\text{ V}$ , $I_D = 13.5\text{ A}$ , $R_G = 4.7\ \Omega$ , $V_{GS} = 10\text{ V}$ (Figure 15 and Figure 20)	-	4 22	-	ns ns
$t_{d(off)}$ $t_f$	Turn-off delay time Fall time	$V_{DD} = 15\text{ V}$ , $I_D = 13.5\text{ A}$ , $R_G = 4.7\ \Omega$ , $V_{GS} = 10\text{ V}$ (Figure 15 and Figure 20)	-	13 2.8	-	ns ns

**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$ $I_{SDM}^{(1)}$	Source-drain current Source-drain current (pulsed)		-		27 108	A A
$V_{SD}$	Forward on voltage	$I_{SD} = 13.5\text{ A}$ , $V_{GS} = 0$	-		1.1	V
$t_{rr}$ $Q_{rr}$ $I_{RRM}$	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 27\text{ A}$ , $di/dt = 100$ $\text{A}/\mu\text{s}$ , $V_{DD} = 25\text{ V}$ (Figure 17)	-	16.2 7.8 1		ns nC A

1. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220

Figure 3. Thermal impedance for TO-220

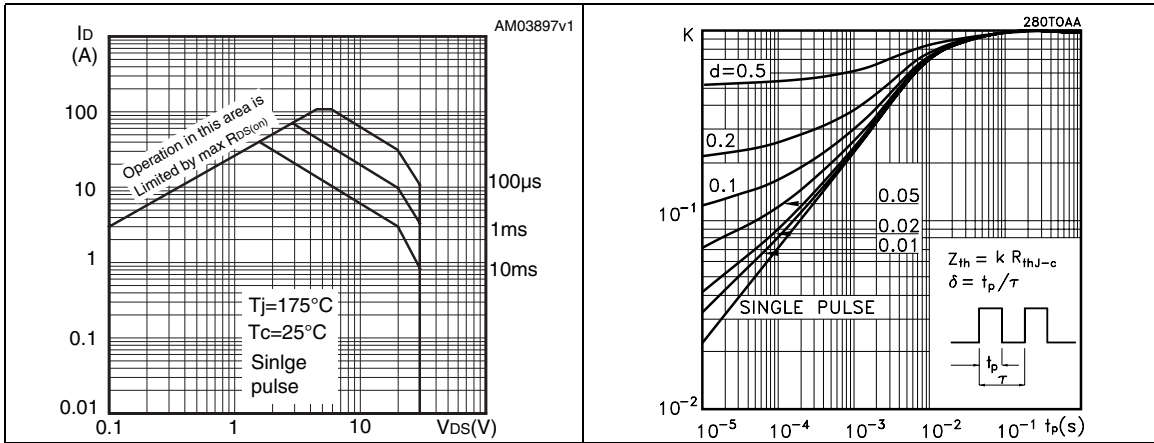


Figure 4. Safe operating area for DPAK, IPAK

Figure 5. Thermal impedance for DPAK, IPAK

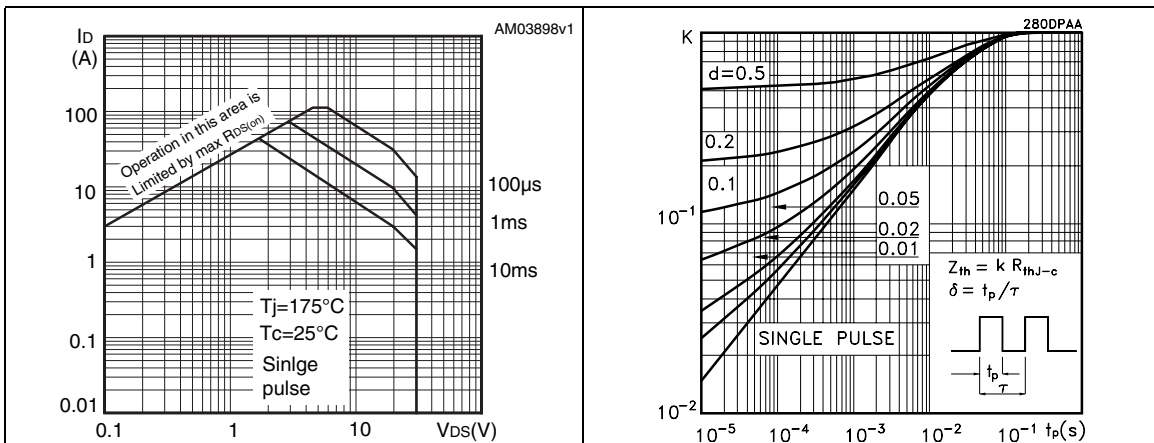


Figure 6. Output characteristics

Figure 7. Transfer characteristics

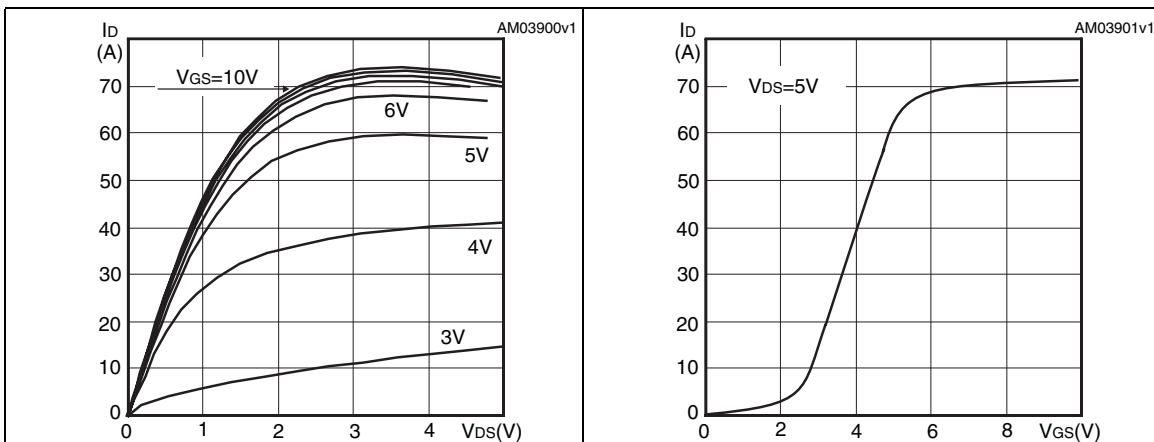


Figure 8. Normalized  $BV_{DSS}$  vs temperature      Figure 9. Static drain-source on resistance

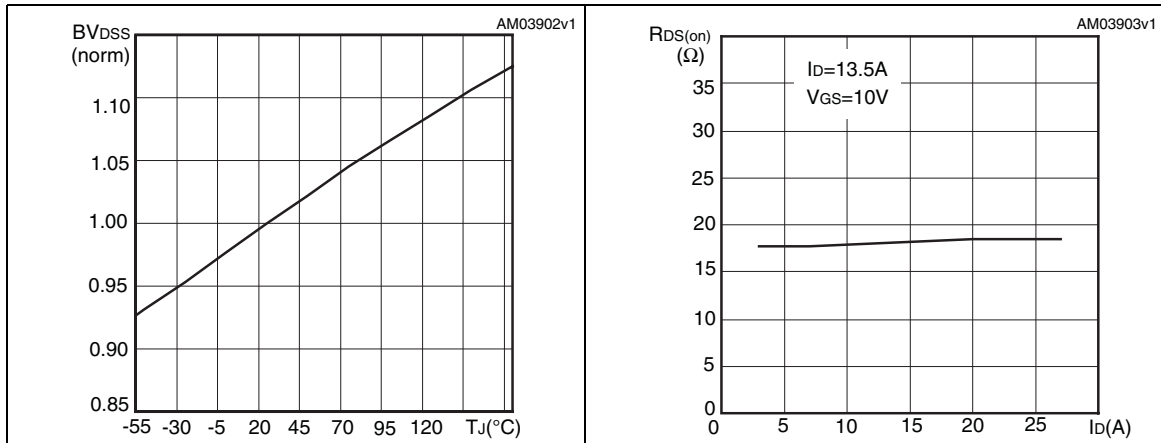


Figure 10. Gate charge vs gate-source voltage      Figure 11. Capacitance variations

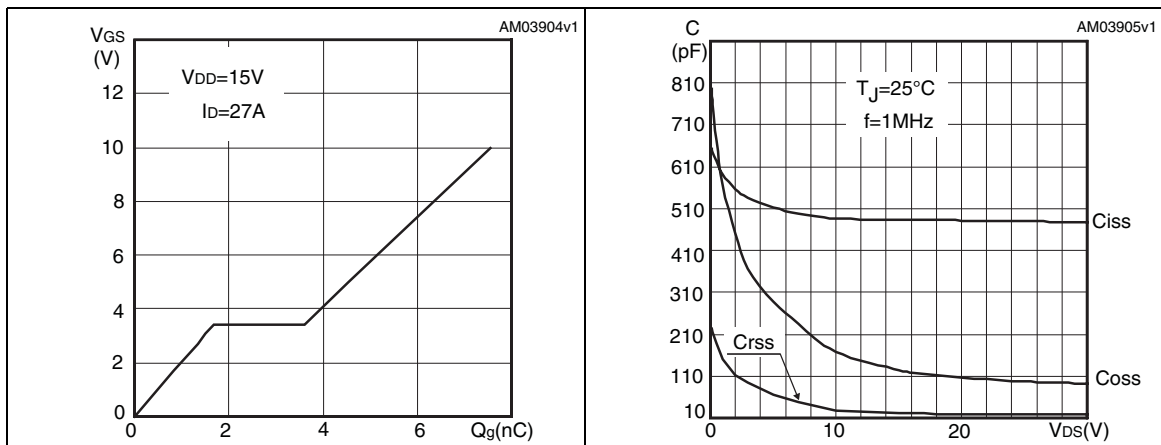
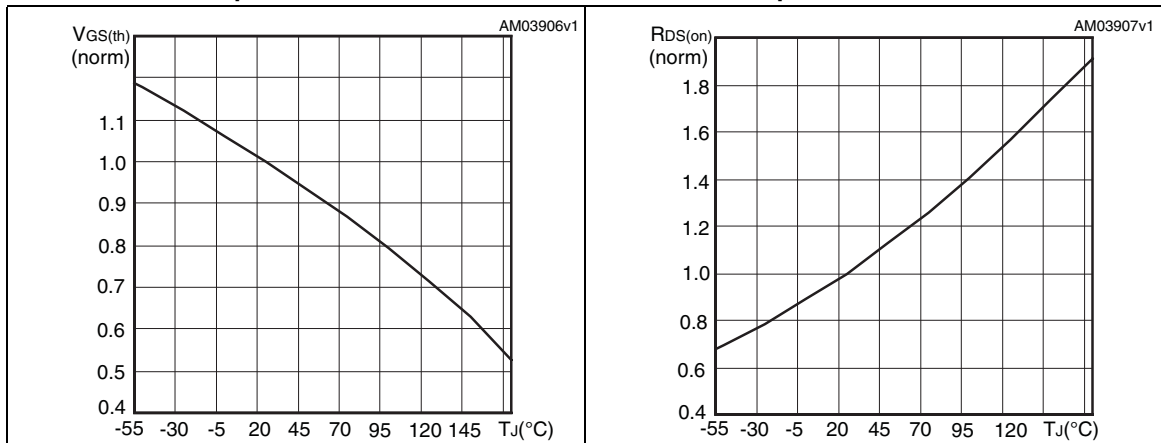
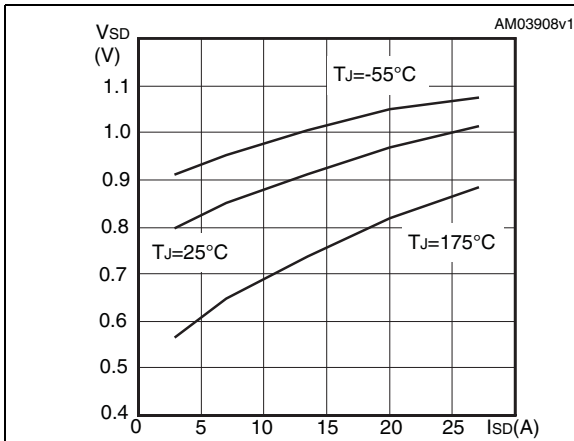


Figure 12. Normalized gate threshold voltage vs temperature      Figure 13. Normalized on resistance vs temperature



**Figure 14. Source-drain diode forward characteristics**



### 3 Test circuits

Figure 15. Switching times test circuit for resistive load

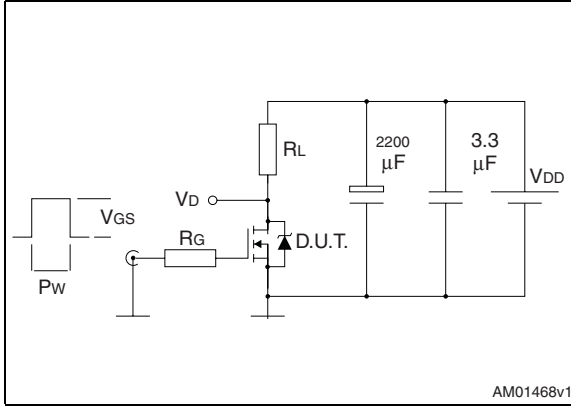


Figure 16. Gate charge test circuit

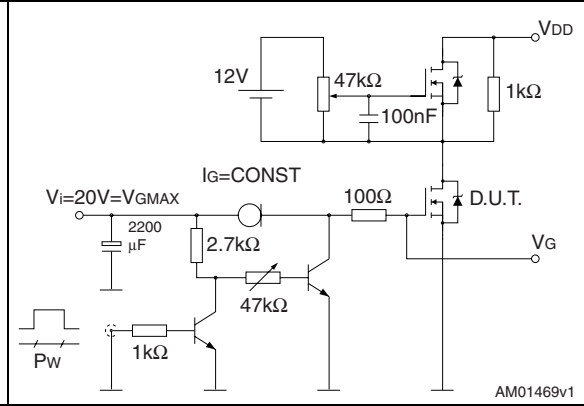


Figure 17. Test circuit for inductive load switching and diode recovery times

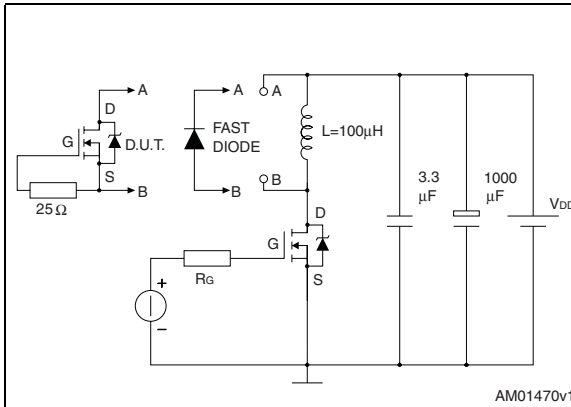


Figure 18. Unclamped inductive load test circuit

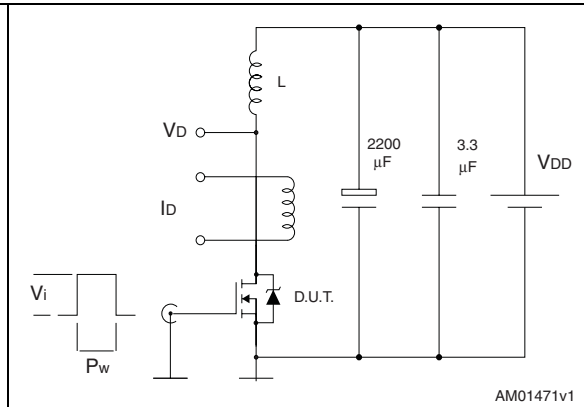


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform

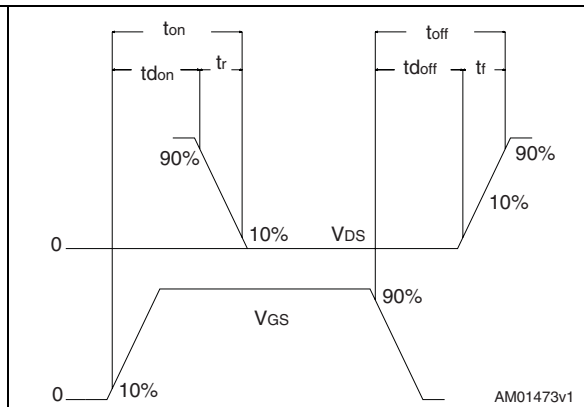
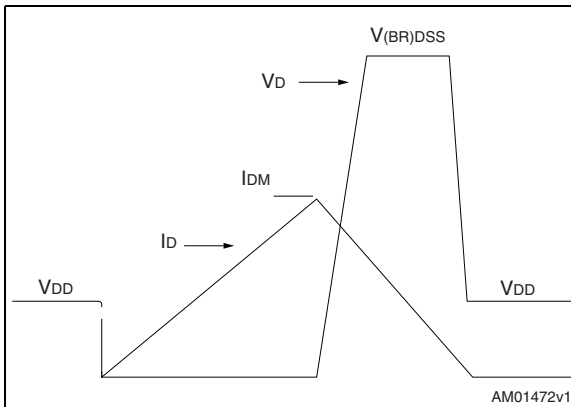
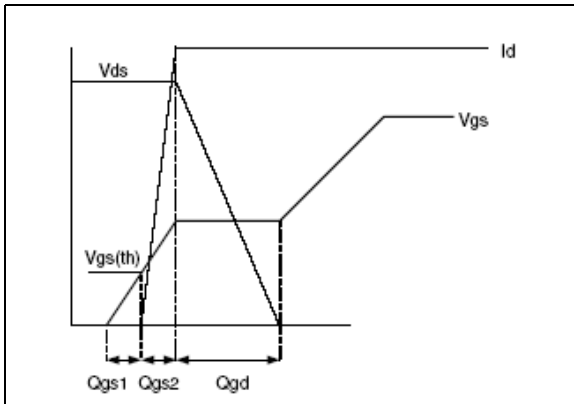


Figure 21. Gate charge waveform

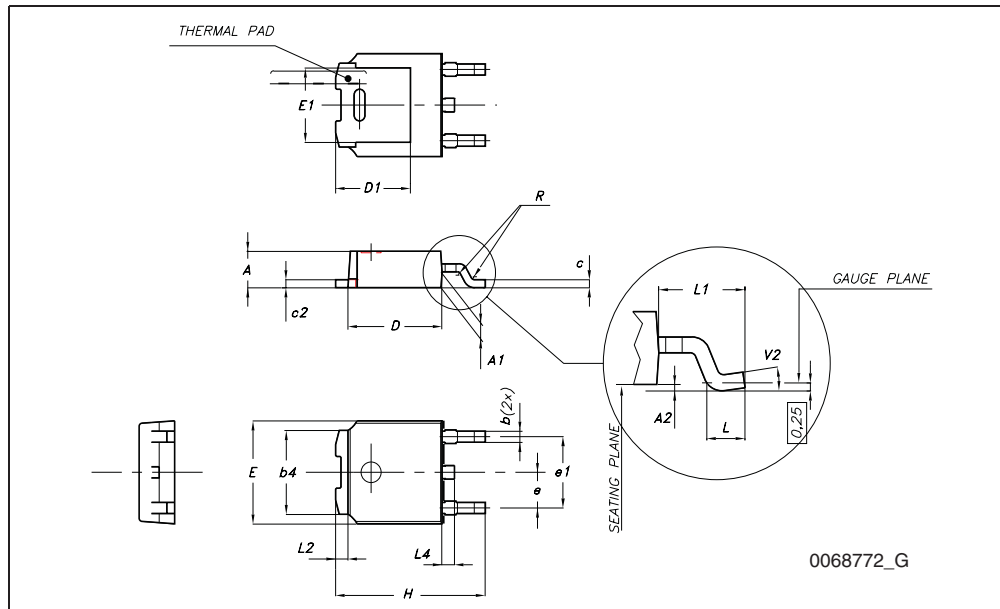


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

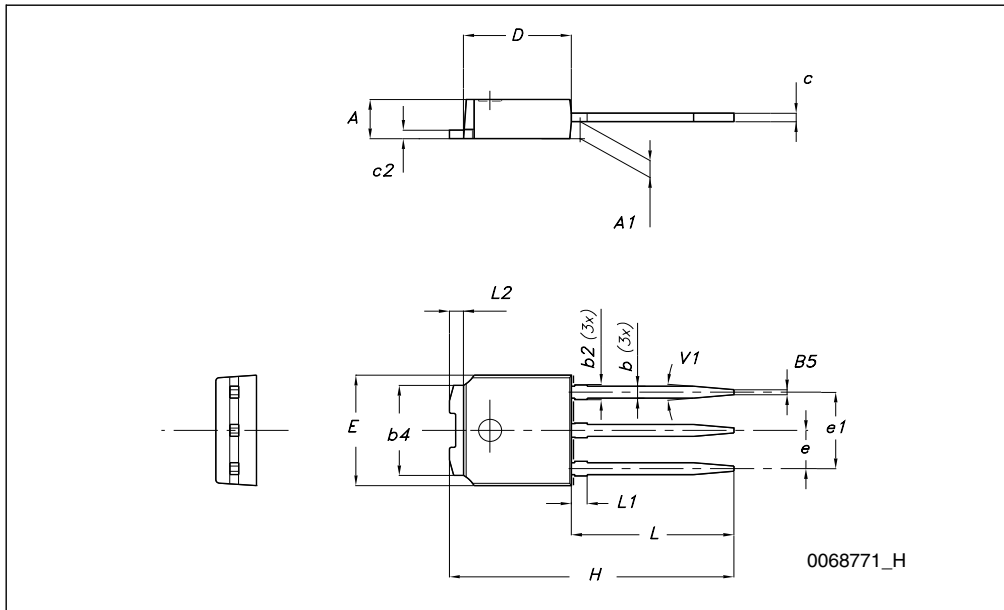
TO-252 (DPAK) mechanical data

DIM.	mm.		
	min.	typ	max.
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
E	6.40		6.60
E1		4.70	
e		2.28	
e1	4.40		4.60
H	9.35		10.10
L	1		
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0°		8°



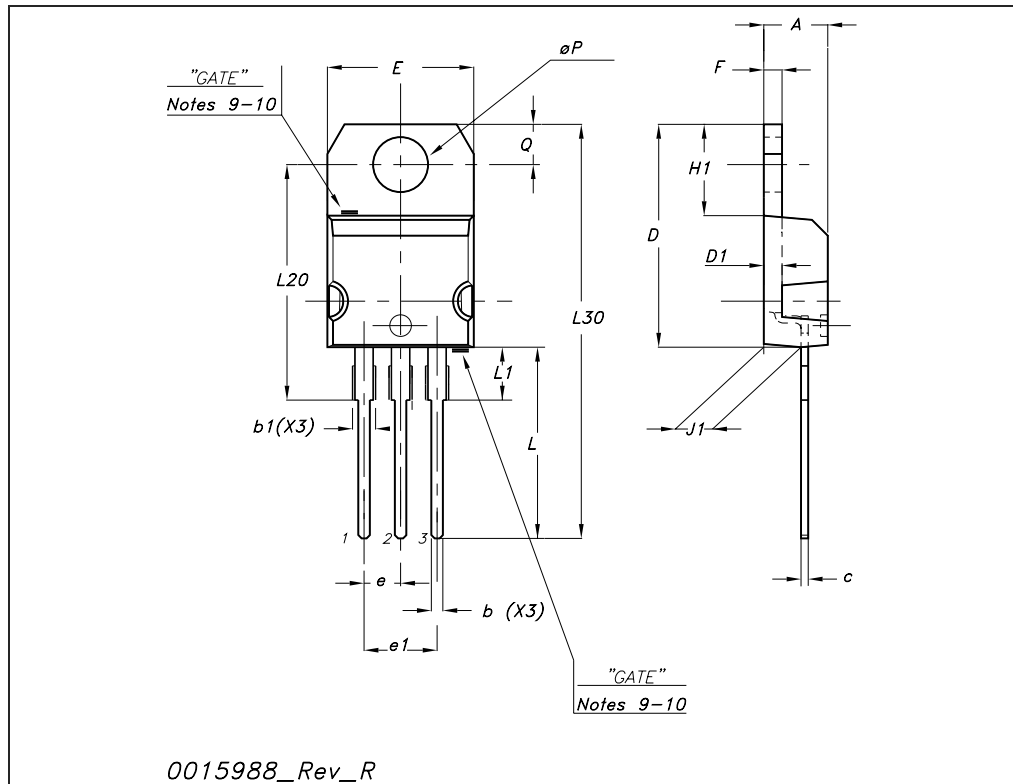
TO-251 (IPAK) mechanical data

DIM.	mm.		
	min.	typ	max.
A	2.20		2.40
A1	0.90		1.10
b	0.64		0.90
b2			0.95
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
E	6.40		6.60
e		2.28	
e1	4.40		4.60
H		16.10	
L	9.00		9.40
(L1)	0.80		1.20
L2		0.80	
V1		10°	



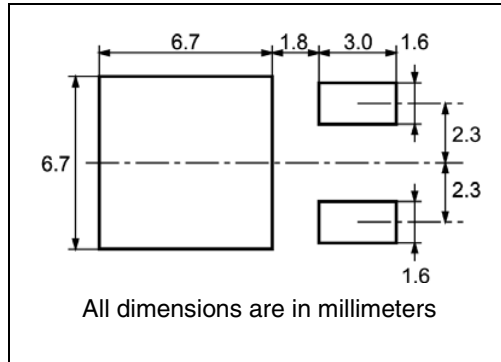
TO-220 mechanical data

Dim	mm			inch		
	Min	Typ	Max	Min	Typ	Max
A	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.14		1.70	0.044		0.066
c	0.48		0.70	0.019		0.027
D	15.25		15.75	0.6		0.62
D1		1.27			0.050	
E	10		10.40	0.393		0.409
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.051
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
∅P	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



## 5 Packaging mechanical data

### DPAK FOOTPRINT



### TAPE AND REEL SHIPMENT

40 mm min. Access hole at slot location

Full radius

Tape slot in core for tape start 2.5mm min. width

G measured at hub

10 pitches cumulative tolerance on tape +/- 0.2 mm

Center line of cavity

For machine ref. only including draft and radii concentric around B0

TRL

R min.

Bending radius

#### REEL MECHANICAL DATA

DIM.	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A		330		12.992
B	1.5		0.059	
C	12.8	13.2	0.504	0.520
D	20.2		0.795	
G	16.4	18.4	0.645	0.724
N	50		1.968	
T		22.4		0.881

BASE QTY	BULK QTY
2500	2500

#### TAPE MECHANICAL DATA

DIM.	mm		inch	
	MIN.	MAX.	MIN.	MAX.
A0	6.8	7	0.267	0.275
B0	10.4	10.6	0.409	0.417
B1		12.1		0.476
D	1.5	1.6	0.059	0.063
D1	1.5		0.059	
E	1.65	1.85	0.065	0.073
F	7.4	7.6	0.291	0.299
K0	2.55	2.75	0.100	0.108
P0	3.9	4.1	0.153	0.161
P1	7.9	8.1	0.311	0.319
P2	1.9	2.1	0.075	0.082
R	40		1.574	
W	15.7	16.3	0.618	0.641

## 6 Revision history

Table 8. Document revision history

Date	Revision	Changes
06-May-2009	1	First release
25-May-2009	2	Updated test condition for $Q_g$ in <a href="#">Table 5: Dynamic</a>



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